

Search Notes

Application/Control No.

10/071,368

Examiner

TUYEN T. NGUYEN

Applicant(s)/Patent under
Reexamination

HASEGAWA ET AL.

Art Unit

2832

SEARCHED

Class	Subclass	Date	Examiner
336	210-213, 233, 234	2/16/2005	TTN
148	304-306	2/16/2005	TTN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR